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FORM PTO-1449		Atty. Docket No. XA-10064	Appln. No. 10/811,902
LIST OF DOCUMENTS CITED BY APPLICANT		Applicant Shoichiro CHIBA et al.	
		Filing Date HEREWITH	Group 2827

## U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date
②	AA	5,581,503	12/03/96	Matsubara et al.	365	185.33	—
	AB	6,201,733 B1	03/13/01	Hiraki et al.	365	185.08	—
	AC	5,561,627	10/01/96	Matsubara et al.	365	185.04	—
	AD	4,659,828	04/21/87	Fong	544	399	—
	AE	5,408,115	04/18/95	Chang	257	324	—
②	AF	6,046,936	04/04/00	Tsujikawa et al.	365	185.03	—
	AG						
	AH						
	AI						

## FOREIGN PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation
②	AJ	5-266219	10/15/93	Japan	—	—	No
	AK	2000-149588	5/30/00	Japan	—	—	No
	AL	7-334999	12/22/95	Japan	—	—	No
	AM	5-136422	06/01/93	Japan	—	—	Abstract
②	AN	11-232886	08/27/99	Japan	—	—	No
	AO						

## OTHER (including author, title, date, pertinent pages, etc.)

②	AP	Sohrab Kianian et al., "A Novel 3 Volts-Only, Small Sector Erase, High Density Flash E2FROM", IEEE, VLSI Technology Symposium, 1994 proceedings", pp. 71 - 72.					
	AQ						
	AR						

Examiner

Sae Seobuon

Date Considered

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XAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.